

Notice of References Cited		Application No. <i>10/083,421</i>		Applicant(s) <i>Hsieh et al</i>	
		Examiner <i>Tom Noland</i>		Group Art Unit <i>2852</i>	Page <i>1</i> of <i>1</i>

U.S. PATENT DOCUMENTS					
*	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS
A	<i>4,069,948</i>	<i>1-1978</i>	<i>Sooty et al</i>	<i>73</i>	<i>1.36</i>
B	<i>4,341,107</i>	<i>7-1982</i>	<i>Blair et al</i>	<i>73</i>	<i>1.34</i>
C	<i>4,671,097</i>	<i>6-1987</i>	<i>Kurki et al</i>	<i>73</i>	<i>1.34</i>
D	<i>5,645,642</i>	<i>7-1997</i>	<i>Nishizato et al</i>	<i>118</i>	<i>712X</i>
E	<i>5,866,795</i>	<i>2-1999</i>	<i>Wang et al</i>	<i>73</i>	<i>1.36</i>
F	<i>5,948,958</i>	<i>9-1999</i>	<i>Bong et al</i>	<i>73</i>	<i>1.36</i>
G	<i>5,968,588</i>	<i>10-1999</i>	<i>Sivaramakrishnan et al</i>	<i>427</i>	<i>8</i>
H	<i>6,117,571</i>	<i>9-2000</i>	<i>Beum et al</i>	<i>428</i>	<i>697</i>
I	<i>6,218,268</i>	<i>4-2001</i>	<i>Xia et al</i>	<i>438</i>	<i>435</i>
J	<i>6,409,837</i>	<i>6-2002</i>	<i>Hillman</i>	<i>118</i>	<i>712</i>
K	<i>2003/0196680</i>	<i>10-2003</i>	<i>Lee et al</i>	<i>134</i>	<i>1.1</i>
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FOREIGN PATENT DOCUMENTS						
*	DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUBCLASS
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R						
S						
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NON-PATENT DOCUMENTS	
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X	

* A copy of this reference is not being furnished with this Office action.
(See Manual of Patent Examining Procedure, Section 707.05(a).)